Search Notes

Application/Control No.	Applicant(s)/Patent und Reexamination	er
10/030,464	FEUSSNER ET AL.	
Examiner	Art Unit	
Yong D. Pak	1652	

SEARCHED				
Class	Subclass	Date	Examiner	
435	189	11/28/2005	ΥP	
435	4	11/28/2005	YP	
435	6	11/28/2005	YP	
435	440	11/28/2005	YP	
435	252.3	11/28/2005	YP	
435	320.1	11/28/2005	YP	
435	69.1	11/28/2005	YP	
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435	25	11/28/2005	YP	
536	23.2	11/28/2005	YP	
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH N (INCLUDING SEARC		 Y)
	DATE	EXMR
stic: seq id no:3	11/28/2005	YP
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inventor search	11/28/2005	YP